

April 1988 Revised October 2000

## 74F825 8-Bit D-Type Flip-Flop

## **General Description**

The 74F825 is an 8-bit buffered register. It has Clock Enable and Clear features which are ideal for parity bus interfacing in high performance microprogramming systems. Also included in the 74F825 are multiple enables that allow multi-user control of the interface.

#### **Features**

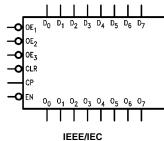
- 3-STATE output
- Clock enable and clear
- Multiple output enables

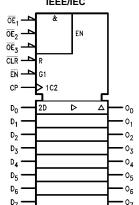
## **Ordering Code:**

Order Number	Package Number	Package Description
74F825SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F825SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

## **Logic Symbols**





## **Connection Diagram**



## **Unit Loading/Fan Out**

Dia Nama	Description	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>		
Pin Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>		
D <sub>0</sub> -D <sub>7</sub>	Data Inputs	1.0/1.0	20 μA/–0.6 mA		
O <sub>0</sub> -O <sub>7</sub>	3-STATE Data Outputs	150/40 (33.3)	-3 mA/24 mA (20 mA)		
$\overline{OE}_1, \overline{OE}_2, \overline{OE}_3$	Output Enable Input	1.0/1.0	20 μA/–0.6 mA		
EN	Clock Enable	1.0/1.0	20 μA/–0.6 mA		
CLR	Clear	1.0/1.0	20 μA/–0.6 mA		
СР	Clock Input	1.0/2.0	20 μA/–1.2 mA		

#### **Functional Description**

The 74F825 consists of eight D-type edge-triggered flip-flops. This device has 3-STATE true outputs and is organized in broadside pinning. In addition to the clock and output enable pins, the buffered clock (CP) and buffered Output Enable ( $\overline{\text{OE}}$ ) are common to all flip-flops. The flip-flops will store the state of their individual D inputs that meet the setup and hold times requirements on the LOW-to-HIGH CP transition. With the  $\overline{\text{OE}}$  LOW the contents of the flip-flops are available at the outputs. When the  $\overline{\text{OE}}$  is HIGH, the outputs go to the high impedance state. Operation of the  $\overline{\text{OE}}$  input does not affect the state of the flip-flops. The 74F825 has Clear ( $\overline{\text{CLR}}$ ) and Clock Enable (EN) pins.

When the  $\overline{\text{CLR}}$  is LOW and the  $\overline{\text{OE}}$  is LOW the outputs are LOW. When  $\overline{\text{CLR}}$  is HIGH, data can be entered into the flip-flops. When  $\overline{\text{EN}}$  is LOW, data on the inputs is transferred to the outputs on the LOW-to-HIGH clock transition. When the  $\overline{\text{EN}}$  is HIGH the outputs do not change state, regardless of the data or clock input transitions.

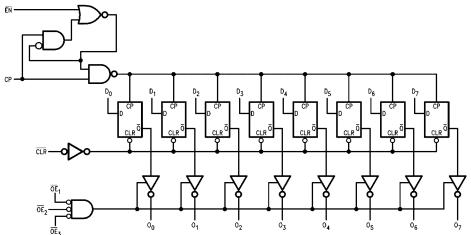
#### **Function Table**

Inputs			Internal	Output	Function		
OE	CLR	EN	СР	D	Q	0	runction
Н	Н	L	Н	Χ	NC	Z	Hold
Н	Н	L	L	Χ	NC	Z	Hold
Н	Н	Н	Χ	Χ	NC	Z	Hold
L	Н	Н	Χ	Χ	NC	NC	Hold
Н	L	Χ	Χ	Χ	Н	Z	Clear
L	L	Χ	Χ	Χ	Н	L	Clear
Н	Н	L	_	L	Н	Z	Load
Н	Н	L	_	Н	L	Z	Load
L	Н	L	_	L	Н	L	Data Available
L	Н	L	_	Н	L	Н	Data Available
L	Н	L	Н	Χ	NC	NC	No Change in Data
L	Н	L	L	Χ	NC	NC	No Change in Data

- L = LOW Voltage Level H = HIGH Voltage Level
- Z = High Impedance

  = LOW-to-HIGH Transition
- X = Immaterial NC = No Change

#### **Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## **Absolute Maximum Ratings**(Note 1)

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias  $-55^{\circ}C$  to  $+150^{\circ}C$ V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0V

Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

Standard Output -0.5V to  $V_{CC}$ 

3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I<sub>OL</sub> (mA)

## **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

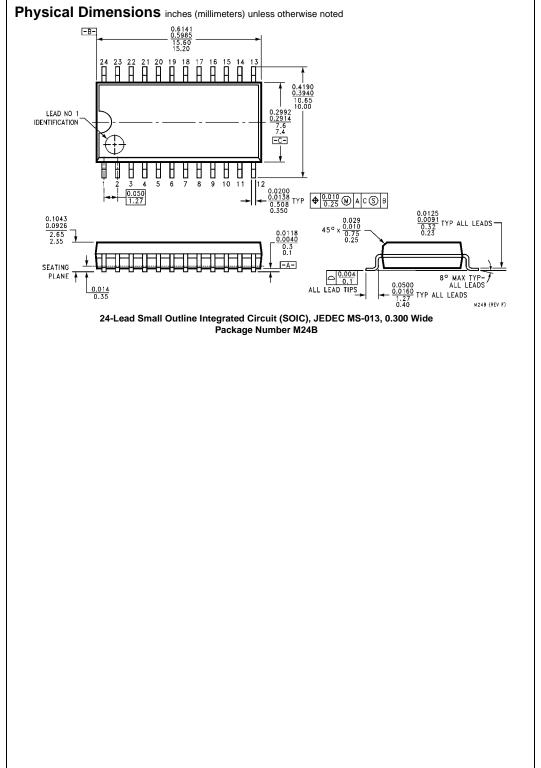
Symbol	Parameter		Min	Тур	Max	Units	v <sub>cc</sub>	Conditions	
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V <sub>IL</sub>	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V <sub>CD</sub>	Input Clamp Diode Voltage				-1.2	V	Min	I <sub>IN</sub> = -18 mA	
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.5					I <sub>OH</sub> = -1 mA	
	Voltage	10% V <sub>CC</sub>	2.4			V	Min	$I_{OH} = -3 \text{ mA}$	
		5% V <sub>CC</sub>	2.7			V	IVIII	$I_{OH} = -1 \text{ mA}$	
		5% V <sub>CC</sub>	2.7					$I_{OH} = -3 \text{ mA}$	
V <sub>OL</sub>	Output LOW Voltage	10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 24 mA	
I <sub>IH</sub>	Input HIGH				5.0	μА	Max	V <sub>IN</sub> = 2.7V	
	Current				3.0	μΛ	IVIAX	V <sub>IN</sub> = 2.7 V	
I <sub>BVI</sub>	Input HIGH Current				7.0	μА	Max	V <sub>IN</sub> = 7.0V	
	Breakdown Test				7.0	μΛ	IVIAX	V <sub>IN</sub> = 7.0 V	
I <sub>CEX</sub>	Output HIGH				50	μА	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
	Leakage Current				00	μιτ	IVICA	*001 - *CC	
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9  \mu A$	
	Test		4./5			V		All Other Pins Grounded	
l <sub>OD</sub>	Output Leakage				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV	
	Circuit Current				3.73	μΛ	0.0	All Other Pins Grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	V <sub>IN</sub> = 0.5V	
l <sub>OZH</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V	
I <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V	
los	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>ZZ</sub>	Buss Drainage Test				500	μΑ	0.0V	V <sub>OUT</sub> = 5.25V	
I <sub>CCZ</sub>	Power Supply Current			75	90	mA	Max	V <sub>O</sub> = HIGH Z	

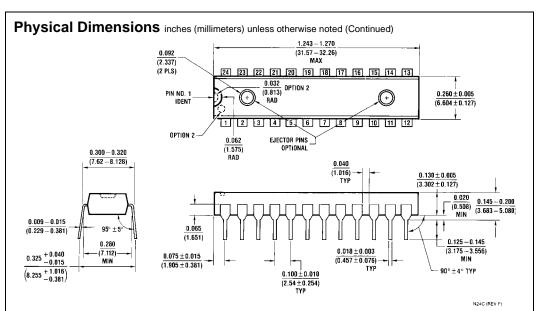
# **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			V <sub>CC</sub> =	to +125°C +5.0V 50 pF	$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF		Units	
		Min	Тур	Max	Min	Max	Min	Max		
f <sub>MAX</sub>	Maximum Clock Frequency	100	160		60		70		MHz	
t <sub>PLH</sub>	Propagation Delay	2.0	6.5	9.5	2.0	10.5	2.0	10.5		
t <sub>PHL</sub>	CP to O <sub>n</sub>	2.0	6.6	9.5	2.0	10.5	2.0	10.5	ns	
t <sub>PHL</sub>	Propagation Delay  CLR to O <sub>n</sub>	4.0	7.4	12.0	4.0	13.0	4.0	13.0	ns	
t <sub>PZH</sub>	Output Enable Time	2.0	6.5	10.5	2.0	13.0	2.0	11.5		
t <sub>PZL</sub>	OE to O <sub>n</sub>	2.0	6.6	10.5	2.0	13.0	2.0	11.5	20	
t <sub>PHZ</sub>	Output Disable TIme	1.5	3.5	7.0	1.0	7.5	1.5	7.5	ns	
t <sub>PLZ</sub>	OE to O <sub>n</sub>	1.5	3.3	7.0	1.0	7.5	1.5	7.5		

## **AC Operating Requirements**

		$T_A = +25$ °C $V_{CC} = +5.0$ V		T <sub>A</sub> = -55°C	to +125°C	$T_A = 0$ °C to +70°C		
Symbol	Parameter			$V_{CC} = +5.0V$		$\mathbf{V_{CC}} = +5.0\mathbf{V}$		Units
		Min	Max	Min	Max	Min	Max	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	2.5		4.0		3.0		
t <sub>S</sub> (L)	D <sub>n</sub> to CP	2.5		4.0		3.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	2.5		2.5		2.5		115
t <sub>H</sub> (L)	D <sub>n</sub> to CP	2.5		2.5		2.5		
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	4.5		5.0		5.0		
t <sub>S</sub> (L)	EN to CP	2.5		3.0		3.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	2.0		3.0		1.0		115
t <sub>H</sub> (L)	EN to CP	0		2.0		0		
t <sub>W</sub> (H)	CP Pulse Width	5.0		6.0		6.0		ns
t <sub>W</sub> (L)	HIGH or LOW	5.0		6.0		6.0		115
t <sub>W</sub> (L)	CLR Pulse Width, LOW	5.0		5.0		5.0		ns
t <sub>REC</sub>	CLR Recovery Time	5.0		5.0		5.0	•	ns





24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N24C

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